



LOW NOISE 150mA LDO REGULATOR

R1112N SERIES

NO. EA-059-0204

OUTLINE

The R1112N Series are CMOS-based voltage regulator ICs with high output voltage accuracy, extremely low supply current, low ON-resistance, and high ripple rejection. Each of these voltage regulator ICs consists of a voltage reference unit, an error amplifier, resistors, a current limit circuit, and a chip enable circuit.

These ICs perform with low dropout voltage and a chip enable function. The line transient response and load transient response of the R1112N Series are excellent, thus these ICs are very suitable for the power supply for hand-held communication equipment.

The output voltage of these ICs is fixed with high accuracy. Since the package for these ICs is SOT-23-5 (Mini-mold) package, high density mounting of the ICs on boards is possible.

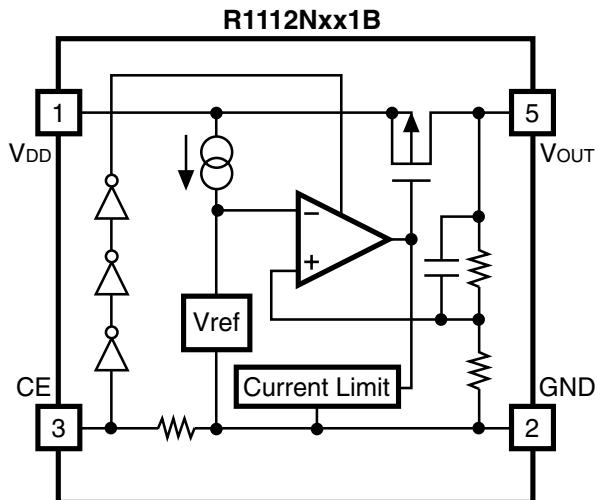
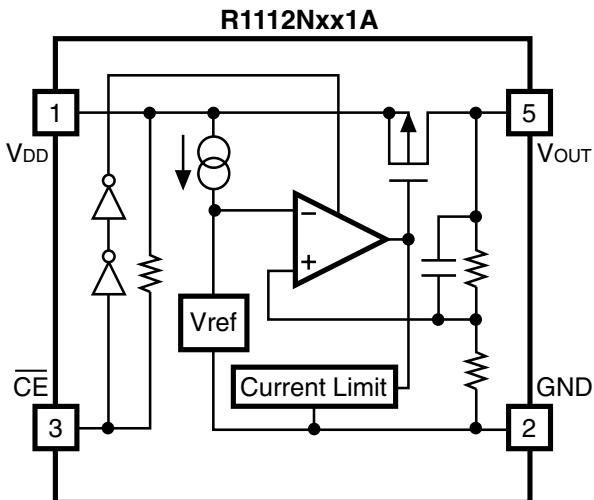
FEATURES

- Ultra-Low Supply Current Typ. 100 μ A
- Standby Mode Current Typ. 0.1 μ A
- Low Dropout Voltage Typ. 0.19V ($I_{OUT}=100mA$ 3.0V Output type)
- High Ripple Rejection Typ. 80dB(f=1kHz)
- Low Temperature-Drift Coefficient of Output Voltage Typ. $\pm 100ppm/^{\circ}C$
- Excellent Line Regulation Typ. 0.05%/V
- High Output Voltage Accuracy $\pm 2.0\%$
- Excellent Dynamic Response
- Small Package SOT-23-5 (Mini-mold)
- Output Voltage Stepwise setting with a step of 0.1V in the range of 1.5V to 5.0V is possible
- Built-in chip enable circuit (2 types; A: active low, B: active high)
- Pin-out Similar to the LP2980/LP2985
- Built-in fold-back protection circuit Typ. 30mA (Current at short mode)
- Ceramic capacitors recommended to be used with this IC

APPLICATIONS

- Power source for cellular phones such as GSM, CDMA and various kind of PCSs.
- Power source for electrical appliances such as cameras, VCRs and camcorders.
- Power source for battery-powered equipment.

BLOCK DIAGRAM



SELECTION GUIDE

The output voltage, the active type, the packing type, and the taping type for the ICs can be selected at the user's request. The selection can be made by designating the part number as shown below:

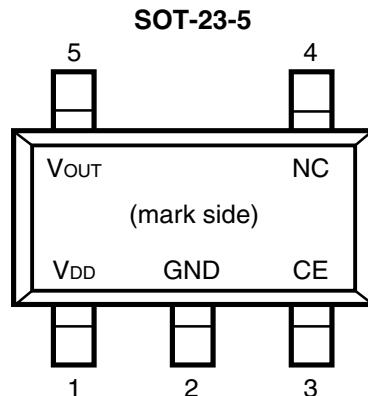
R1112xxx1x-xx ←Part Number

↑↑ ↑↑

a b c d

Code	Contents
a	Designation of Package Type: N: SOT-23-5 (Mini-mold)
b	Setting Output Voltage (VOUT): Stepwise setting with a step of 0.1V in the range of 1.5V to 5.0V is possible.
c	Designation of Active Type: A: active low type B: active high type
d	Designation of Taping Type: Ex. TR, TL (refer to Taping Specifications; TR type is the standard direction.)

PIN CONFIGURATION



PIN DESCRIPTION

Pin No.	Symbol	Description
1	V _{DD}	Input Pin
2	GND	Ground Pin
3	\overline{CE} or CE	Chip Enable Pin
4	NC	No Connection
5	V _{OUT}	Output pin

ABSOLUTE MAXIMUM RATINGS

Symbol	Item	Rating	Unit
V _{IN}	Input Voltage	7.0	V
V _{CE}	Input Voltage(\overline{CE} or CE Pin)	-0.3 ~ V _{IN} +0.3	V
V _{OUT}	Output Voltage	-0.3 ~ V _{IN} +0.3	V
I _{OUT}	Output Current	200	mA
P _D	Power Dissipation	250	mW
T _{opt}	Operating Temperature Range	-40 ~ 85	°C
T _{stg}	Storage Temperature Range	-55 ~ 125	°C

ELECTRICAL CHARACTERISTICS

- R1112Nxx1A

Topt=25°C

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{OUT}	Output Voltage	V _{IN} = Set V _{OUT} +1V 1mA ≤ I _{OUT} ≤ 30mA	V _{OUT} ×0.98		V _{OUT} ×1.02	V
I _{OUT}	Output Current	V _{IN} - V _{OUT} = 1.0V	150			mA
ΔV _{OUT} /ΔI _{OUT}	Load Regulation	V _{IN} = Set V _{OUT} +1V 1mA ≤ I _{OUT} ≤ 80mA		12	40	mV
V _{DIF}	Dropout Voltage	Refer to the ELECTRICAL CHARACTERISTICS by OUTPUT VOLTAGE				
I _{SS}	Supply Current	V _{IN} = Set V _{OUT} +1V		100	170	μA
I _{Standby}	Supply Current (Standby)	V _{IN} = V _{CE} = Set V _{OUT} +1V		0.1	1.0	μA
ΔV _{OUT} /ΔV _{IN}	Line Regulation	Set V _{OUT} +0.5V ≤ V _{IN} ≤ 6V I _{OUT} = 30mA		0.05	0.20	%/V
RR	Ripple Rejection	f = 1kHz, Ripple 0.5Vp-p V _{IN} = Set V _{OUT} +1V		80		dB
V _{IN}	Input Voltage		2.0		6.0	V
ΔV _{OUT} /ΔT	Output Voltage Temperature Coefficient	I _{OUT} = 30mA -40°C ≤ Topt ≤ 85°C		±100		ppm /°C
I _{lim}	Short Current Limit	V _{OUT} = 0V		30		mA
R _{PU}	CE Pull-up Resistance		2.5	5.0	10.0	MΩ
V _{CEH}	CE Input Voltage "H"		1.5		V _{IN}	V
V _{CEL}	CE Input Voltage "L"		0.00		0.25	V
en	Output Noise	BW=10Hz to 100kHz		30		μVrms

- R1112Nxx1B

Topt=25°C

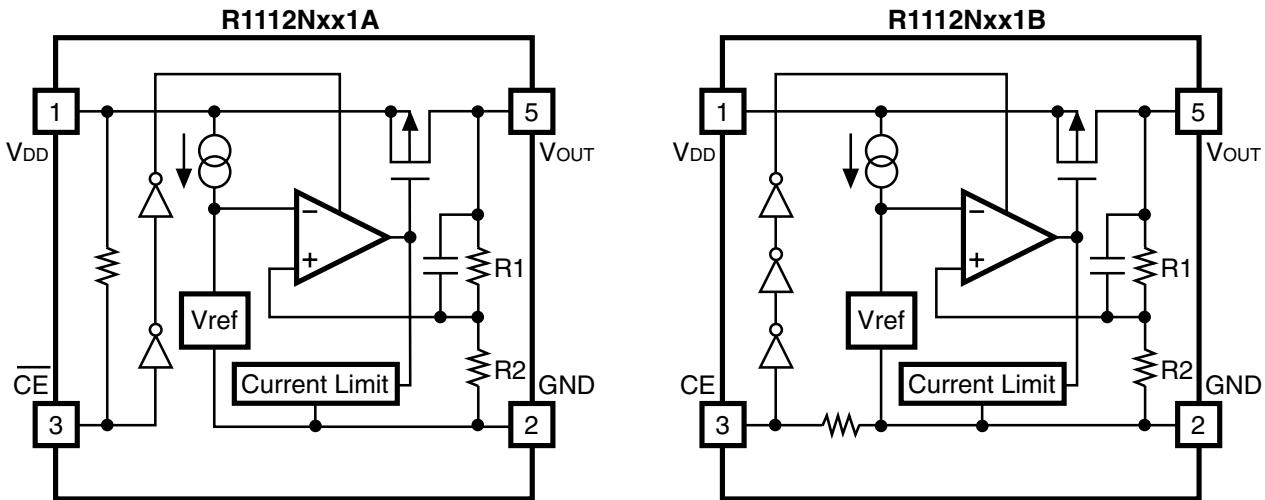
Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{OUT}	Output Voltage	V _{IN} = Set V _{OUT} +1V 1mA ≤ I _{OUT} ≤ 30mA	V _{OUT} ×0.98		V _{OUT} ×1.02	V
I _{OUT}	Output Current	V _{IN} - V _{OUT} = 1.0V	150			mA
ΔV _{OUT} /ΔI _{OUT}	Load Regulation	V _{IN} = Set V _{OUT} +1V 1mA ≤ I _{OUT} ≤ 80mA		12	40	mV
V _{DIF}	Dropout Voltage	Refer to the ELECTRICAL CHARACTERISTICS by OUTPUT VOLTAGE				
I _{SS}	Supply Current	V _{IN} = Set V _{OUT} +1V		100	170	μA
I _{standby}	Supply Current (Standby)	V _{IN} = Set V _{OUT} +1V V _{CE} =GND		0.1	1.0	μA
ΔV _{OUT} /ΔV _{IN}	Line Regulation	Set V _{OUT} +0.5V ≤ V _{IN} ≤ 6V I _{OUT} = 30mA		0.05	0.20	%/V
RR	Ripple Rejection	f = 1kHz, Ripple 0.5Vp-p V _{IN} = Set V _{OUT} +1V		80		dB
V _{IN}	Input Voltage		2.0		6.0	V
ΔV _{OUT} /ΔT	Output Voltage Temperature Coefficient	I _{OUT} = 30mA -40°C ≤ Top t ≤ 85°C		±100		ppm /°C
I _{lim}	Short Current Limit	V _{OUT} = 0V		30		mA
R _{PD}	CE Pull-down Resistance		2.5	5.0	10.0	MΩ
V _{CEH}	CE Input Voltage "H"		1.5		V _{IN}	V
V _{CEL}	CE Input Voltage "L"		0.00		0.25	V
en	Output Noise	BW=10Hz to 100kHz		30		μVrms

- ELECTRICAL CHARACTERISTICS by OUTPUT VOLTAGE

Topt = 25°C

Output Voltage V _{OUT} (V)	Dropout Voltage		
	V _{DIF} (V)		
	Condition	Typ.	Max.
1.5 ≤ V _{OUT} ≤ 1.6	I _{OUT} = 100mA	0.32	0.55
1.7 ≤ V _{OUT} ≤ 1.8		0.28	0.47
1.9 ≤ V _{OUT} ≤ 2.3		0.25	0.35
2.4 ≤ V _{OUT} ≤ 2.7		0.20	0.29
2.8 ≤ V _{OUT} ≤ 5.0		0.19	0.26

OPERATION



In these ICs, fluctuation of the output voltage, V_{out} is detected by feed-back registers R₁, R₂, and the result is compared with a reference voltage by the error amplifier, so that a constant voltage is output. A current limit circuit for protection in short mode and a chip enable circuit, are included.

TECHNICAL NOTES

When using these ICs, consider the following points:

Phase Compensation

In these ICs, phase compensation is made for securing stable operation even if the load current is varied. For this purpose, be sure to use a capacitor C_{out} with good frequency characteristics and ESR (Equivalent Series Resistance). We use Ceramic Capacitors for evaluation of these ICs.

Recommended Capacitors; GRM40X5R225K6.3 (Murata)

GRM40-034X5R335K6.3 (Murata)

GRM40-034X5R475K6.3 (Murata)

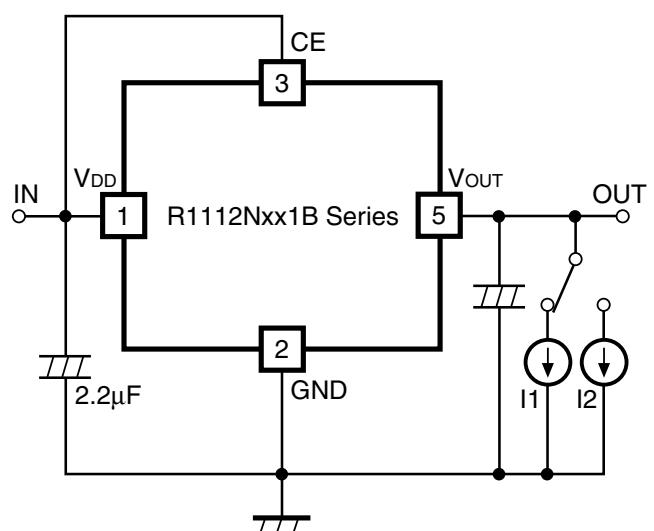
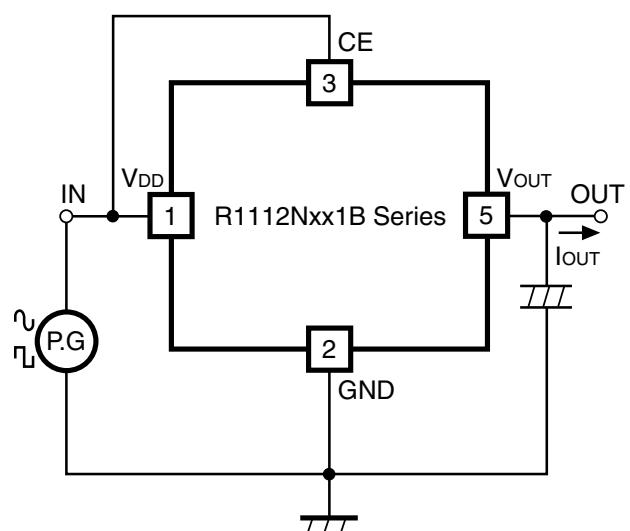
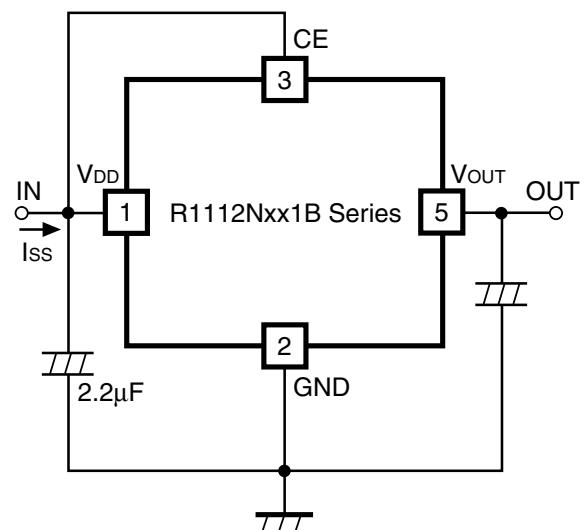
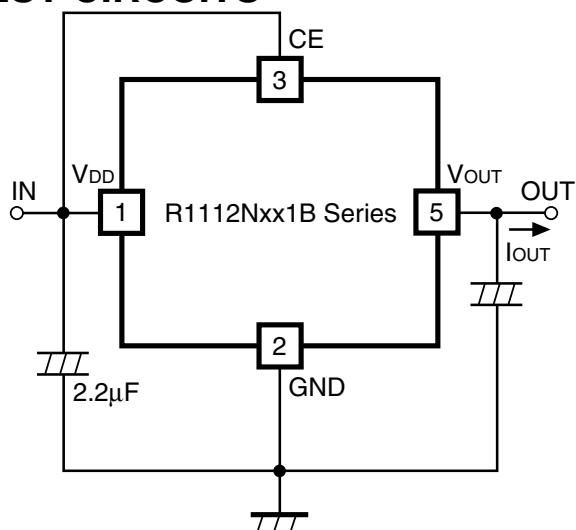
(Note: When the additional ceramic capacitors are connected to the Output Pin with Output capacitor for phase compensation, the operation might be unstable. Because of this, test these ICs with as same external components as ones to be used on the PCB.)

PCB Layout

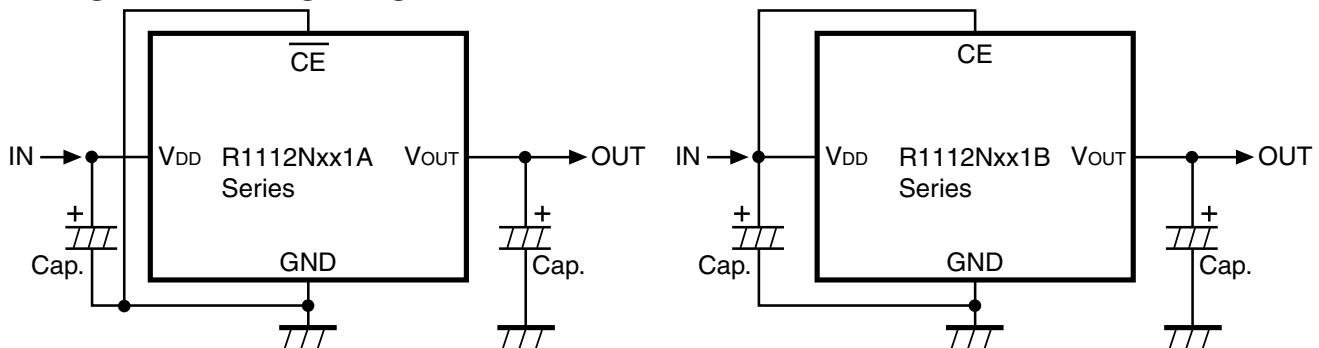
Make V_{DD} and GND lines sufficient. If their impedance is high, picking up the noise or unstable operation may result. Connect a capacitor with a capacitance value of 2.2μF or more between V_{DD} and GND pin as close as possible.

Set external components, especially output capacitor as close as possible to the ICs and make wiring as short as possible.

TEST CIRCUITS



TYPICAL APPLICATION



(External Components)

Output Capacitor; Ceramic 2.2μF (Set Output Voltage in the range from 2.5 to 5.0V)

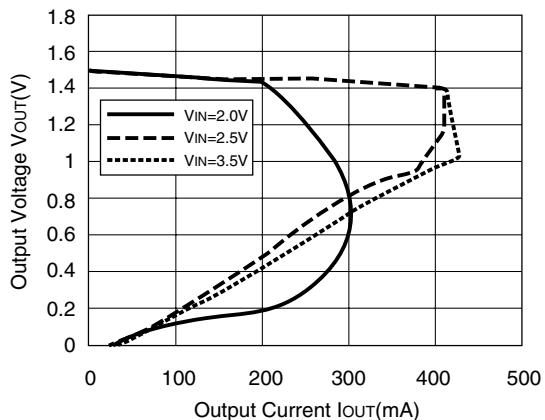
Ceramic 4.7μF (Set Output Voltage in the range from 1.5 to 2.5V)

Input Capacitor; Ceramic 2.2μF

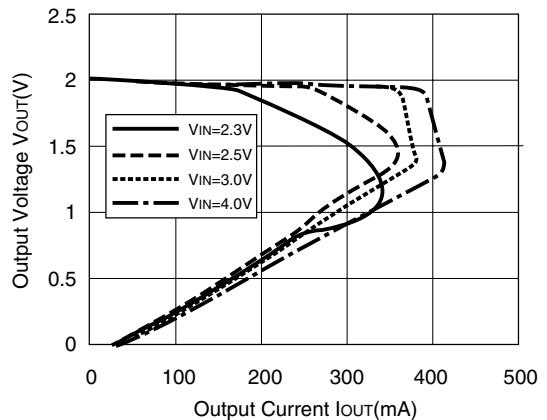
TYPICAL CHARACTERISTICS

1) Output Voltage vs. Output Current

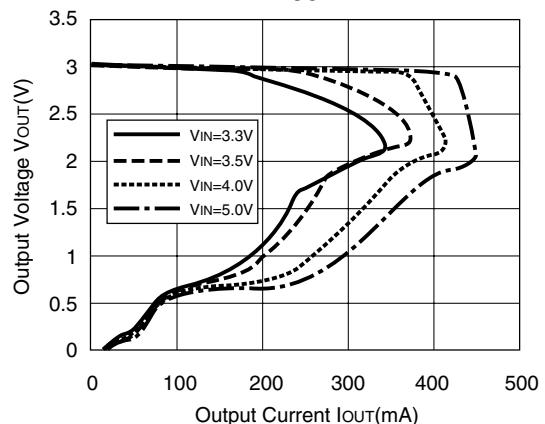
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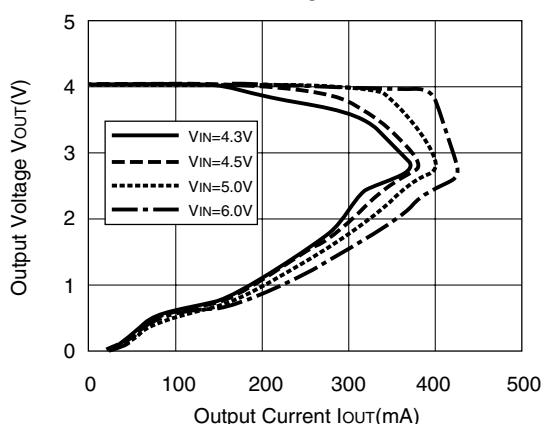
R11x2N201B



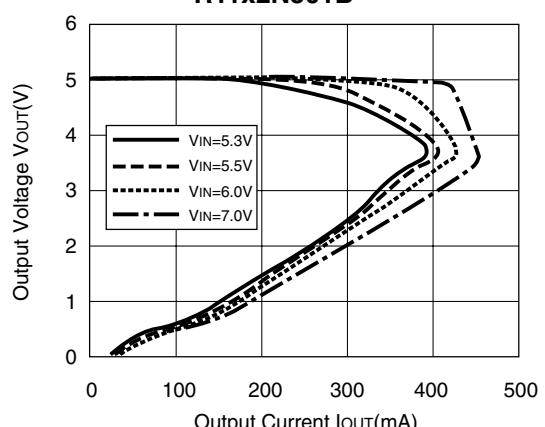
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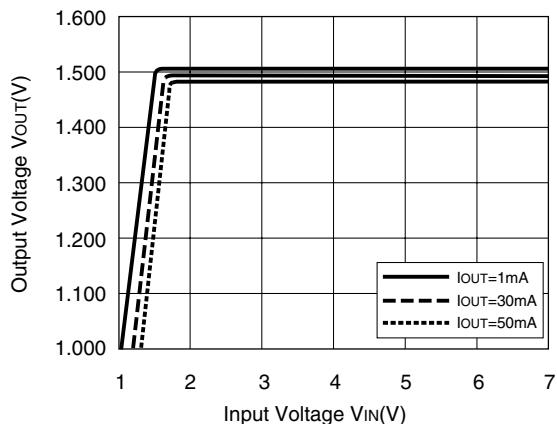
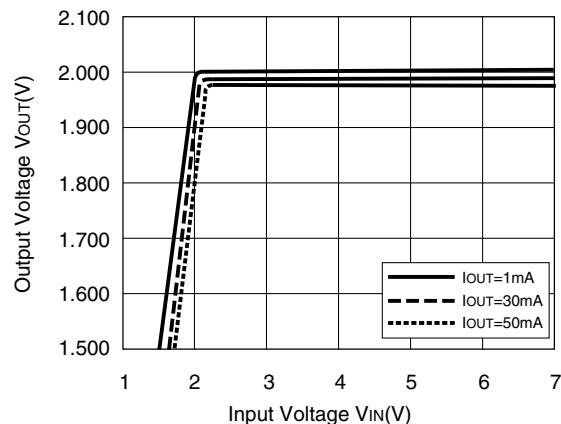
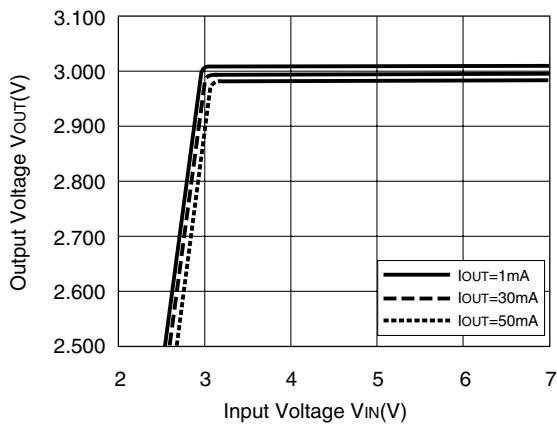
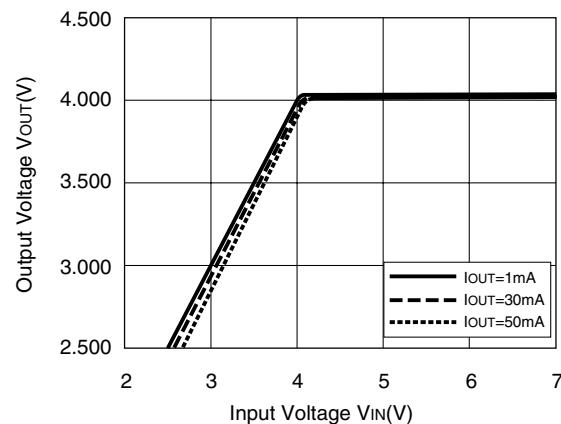
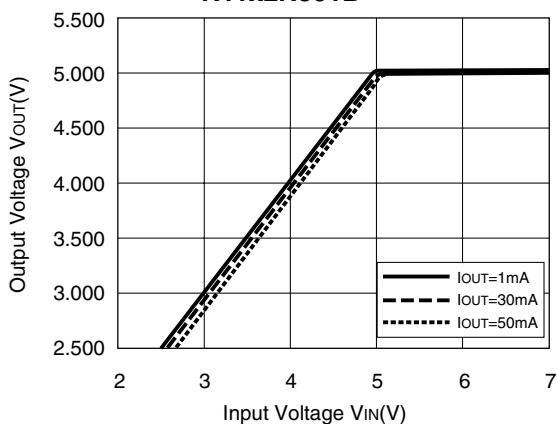
R11x2N401B



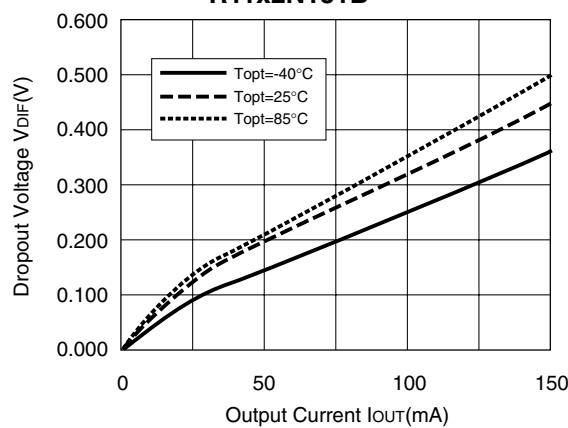
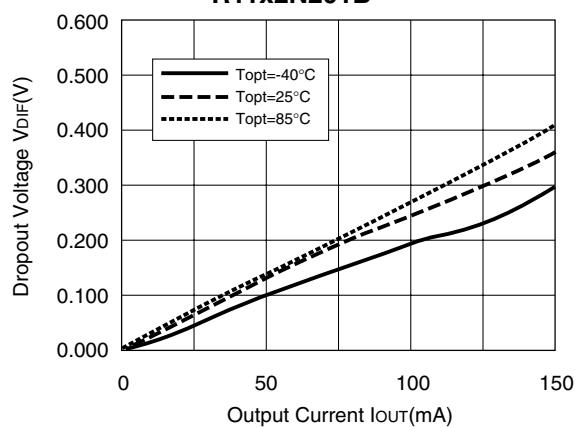
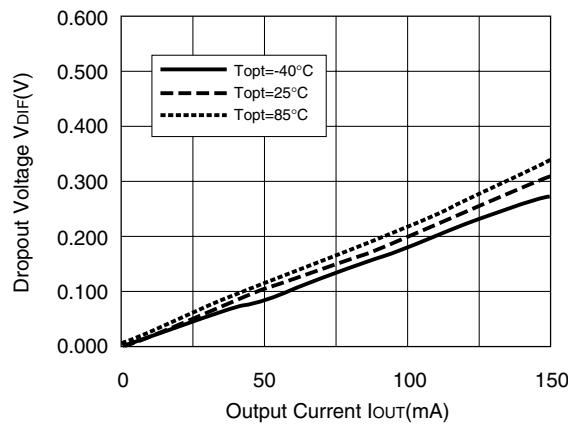
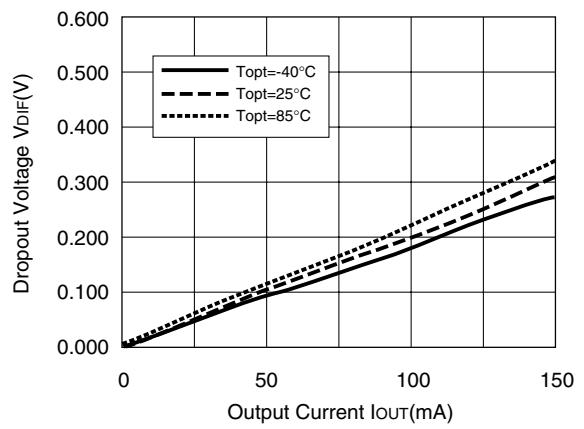
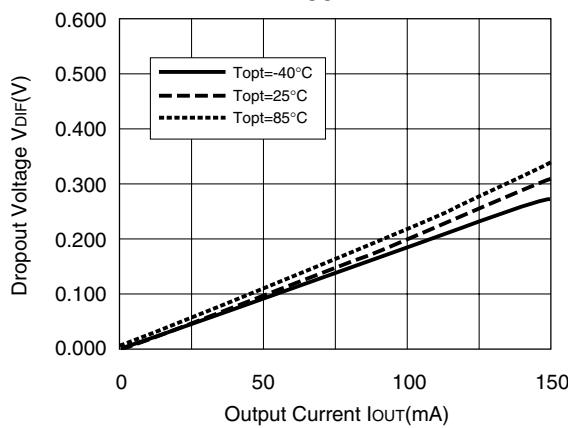
R11x2N501B



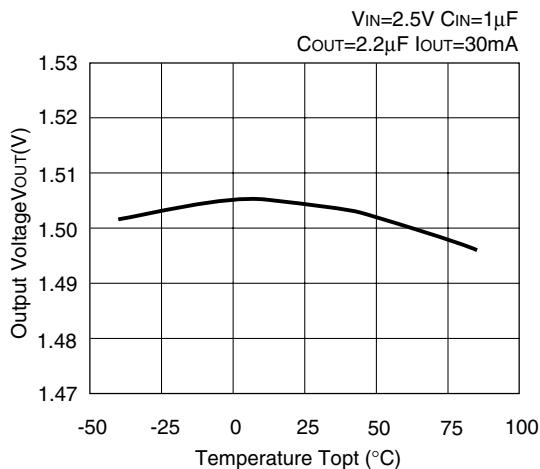
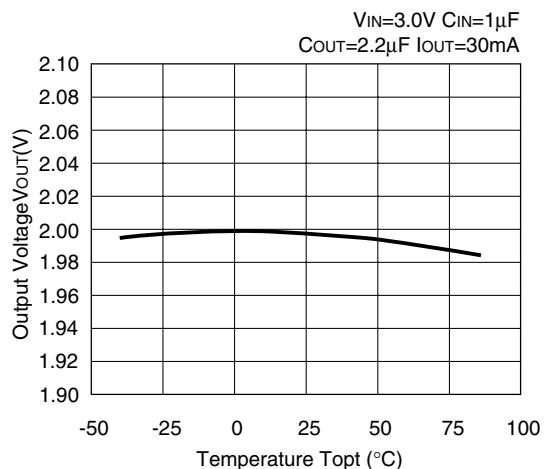
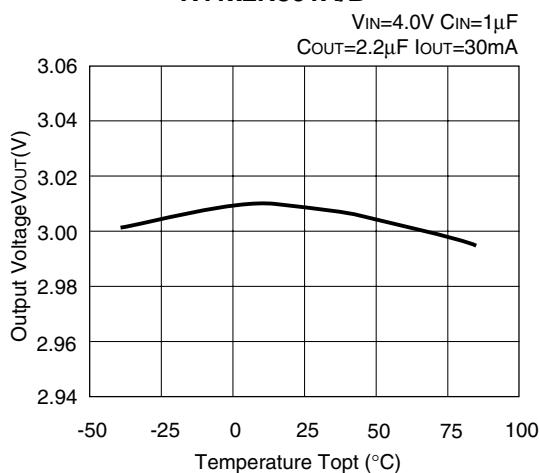
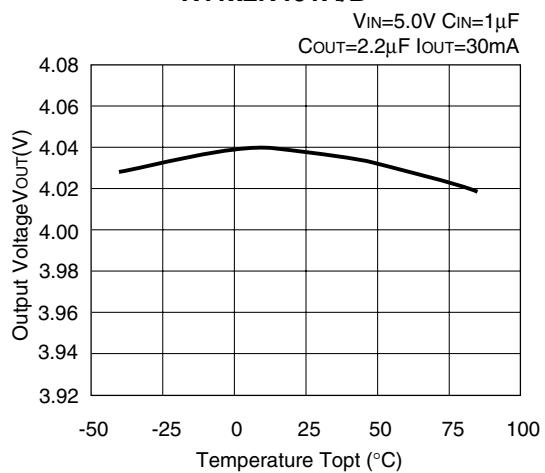
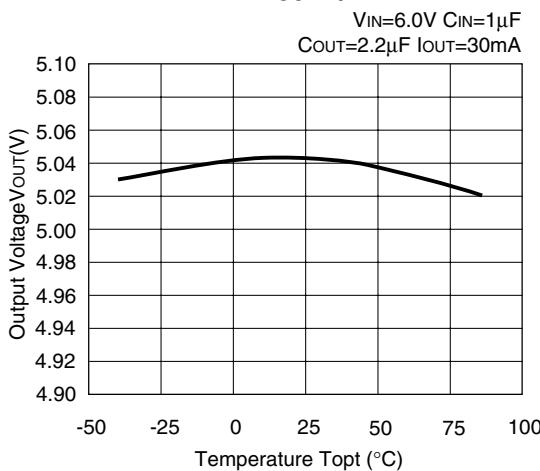
2) Output Voltage vs. Input Voltage

R11x2N151B**R11x2N201B****R11x2N301B****R11x2N401B****R11x2N501B**

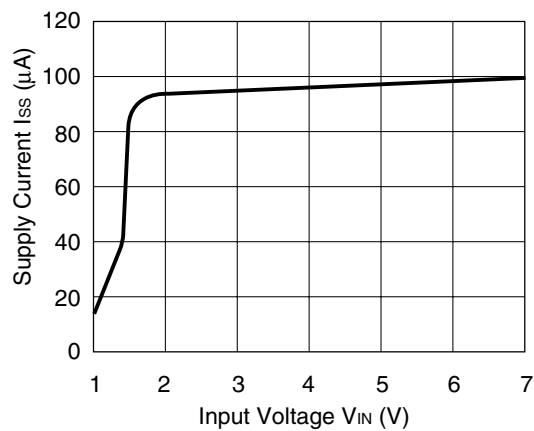
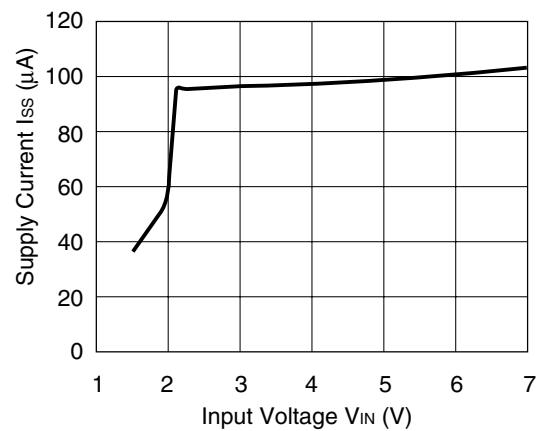
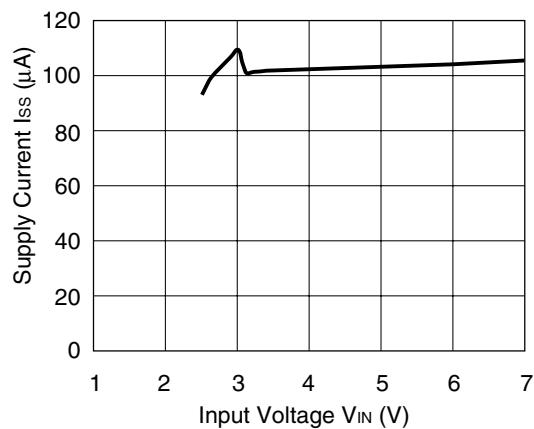
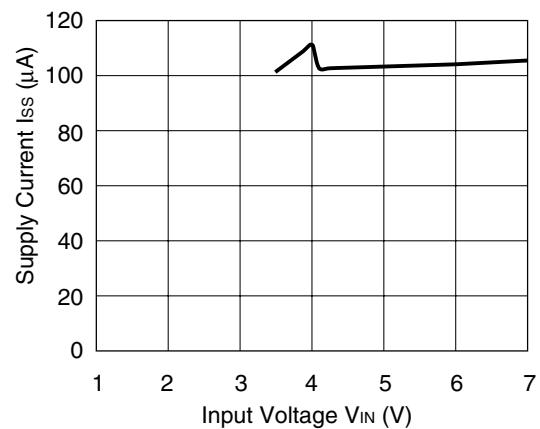
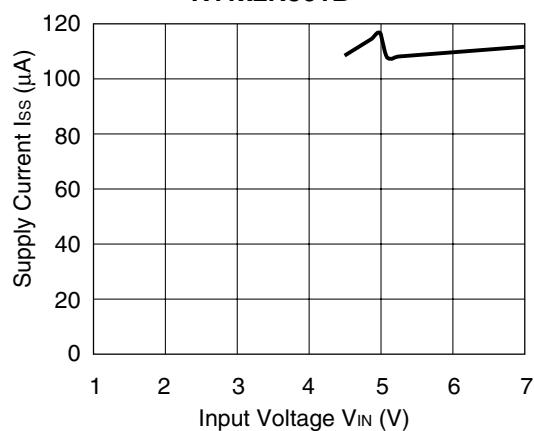
3) Dropout Voltage vs. Output Current

R11x2N151B**R11x2N201B****R11x2N301B****R11x2N401B****R11x2N501B**

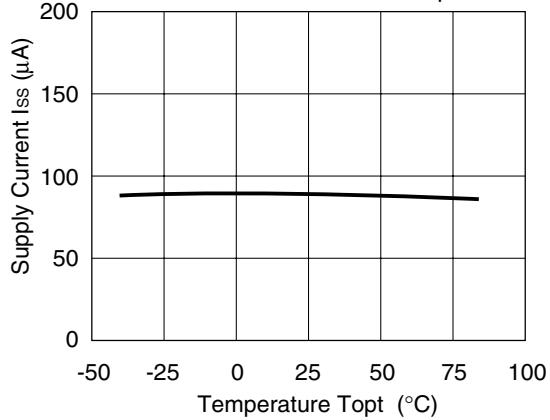
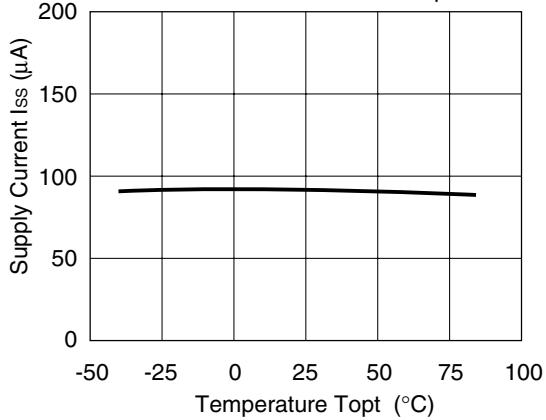
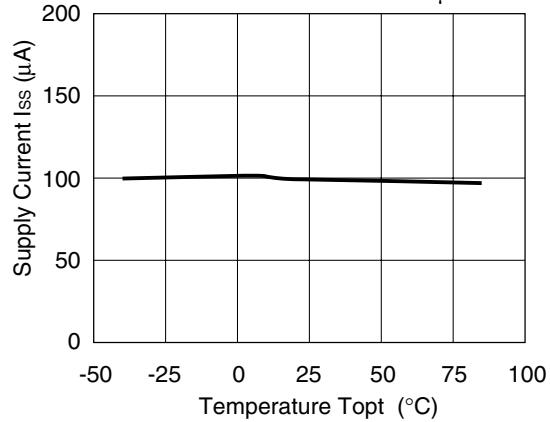
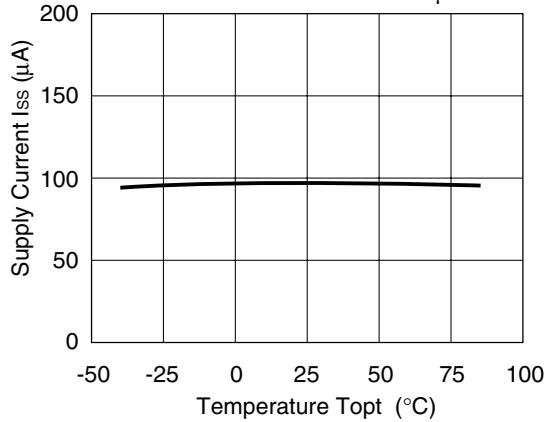
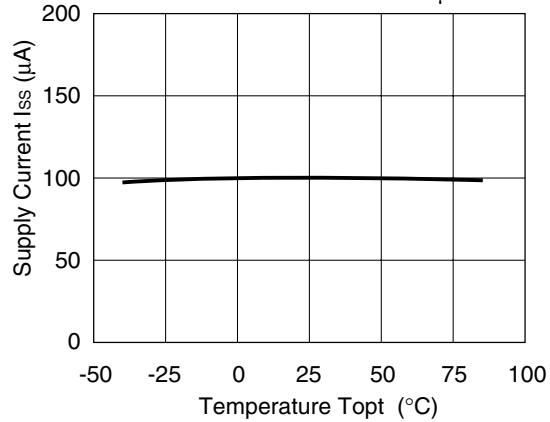
4) Output Voltage vs. Temperature

R11x2N151A/B**R11x2N201B****R11x2N301A/B****R11x2N401A/B****R11x2N501A/B**

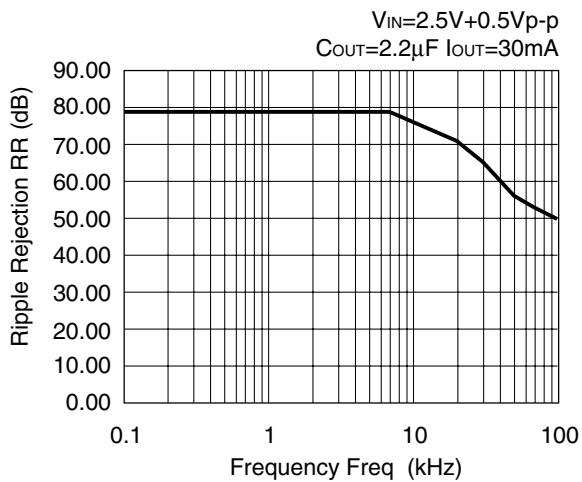
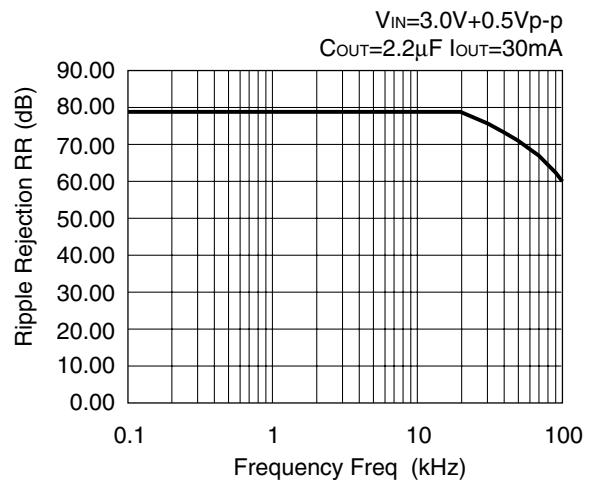
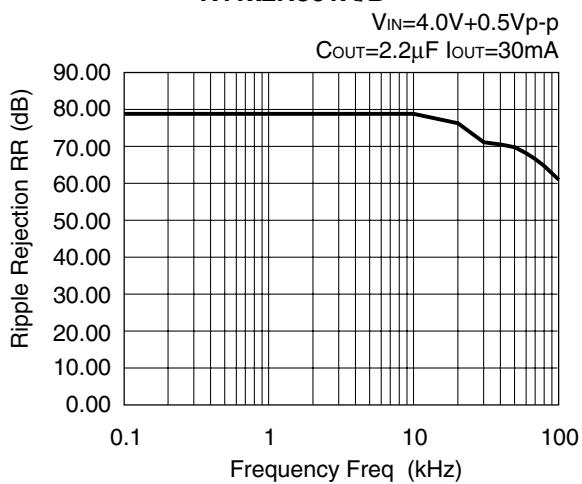
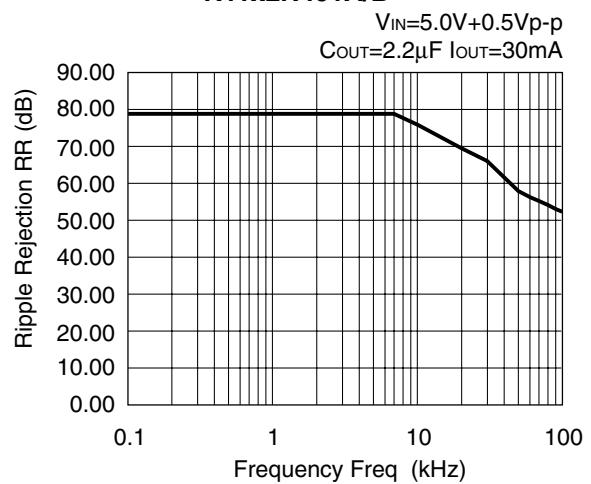
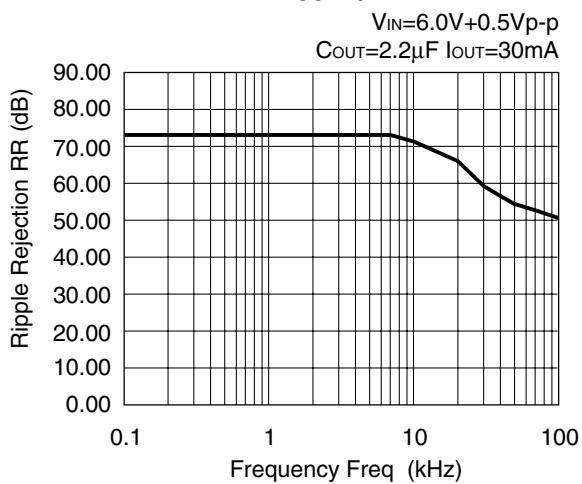
5) Supply Current vs. Input Voltage

R11x2N151B**R11x2N201B****R11x2N301B****R11x2N401B****R11x2N501B**

6) Supply Current vs. Temperature

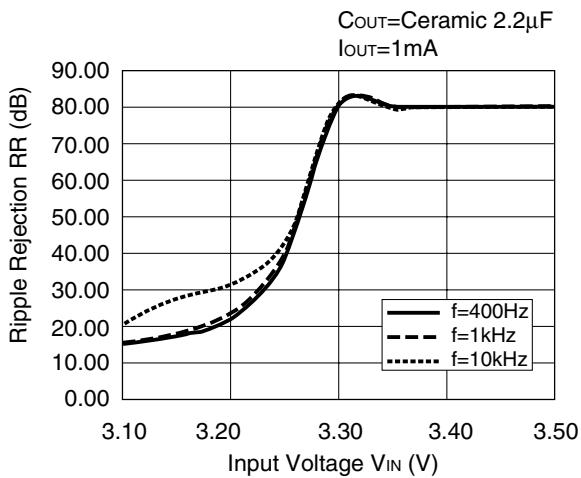
R11x2N151A/B $V_{IN}=2.5V$ $C_{IN}=1\mu F$
 $C_{OUT}=2.2\mu F$ **R11x2N201A/B** $V_{IN}=3.0V$ $C_{IN}=1\mu F$
 $C_{OUT}=2.2\mu F$ **R11x2N301A/B** $V_{IN}=4.0V$ $C_{IN}=1\mu F$
 $C_{OUT}=2.2\mu F$ **R11x2N401A/B** $V_{IN}=5.0V$ $C_{IN}=1\mu F$
 $C_{OUT}=2.2\mu F$ **R11x2N501A/B** $V_{IN}=6.0V$ $C_{IN}=1\mu F$
 $C_{OUT}=2.2\mu F$ 

7) Ripple Rejection vs. Frequency

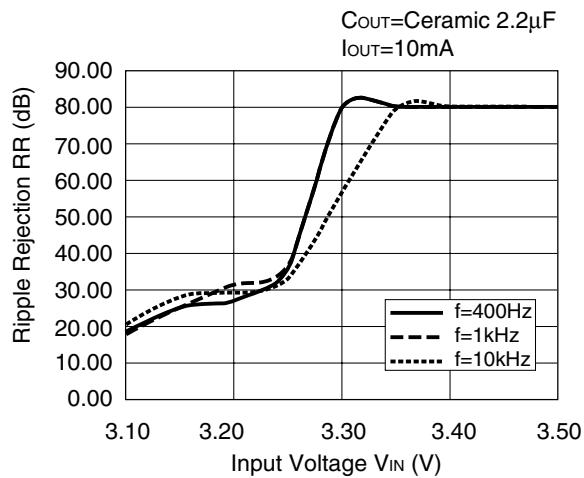
R11x2N151A/B**R11x2N201A/B****R11x2N301A/B****R11x2N401A/B****R11x2N501A/B**

8) Ripple Rejection vs. Input Voltage (DC bias)

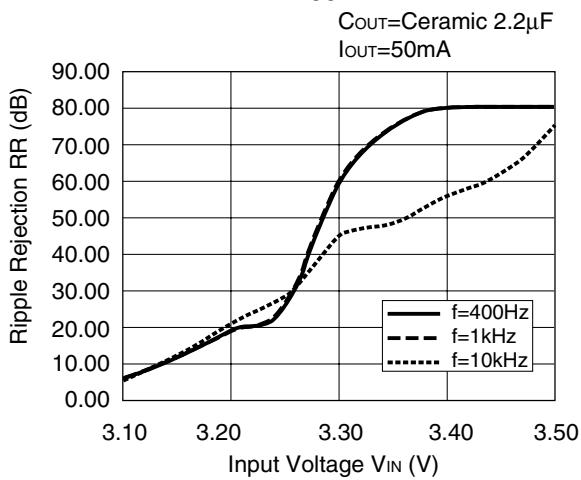
R11x2N301B



R11x2N301B



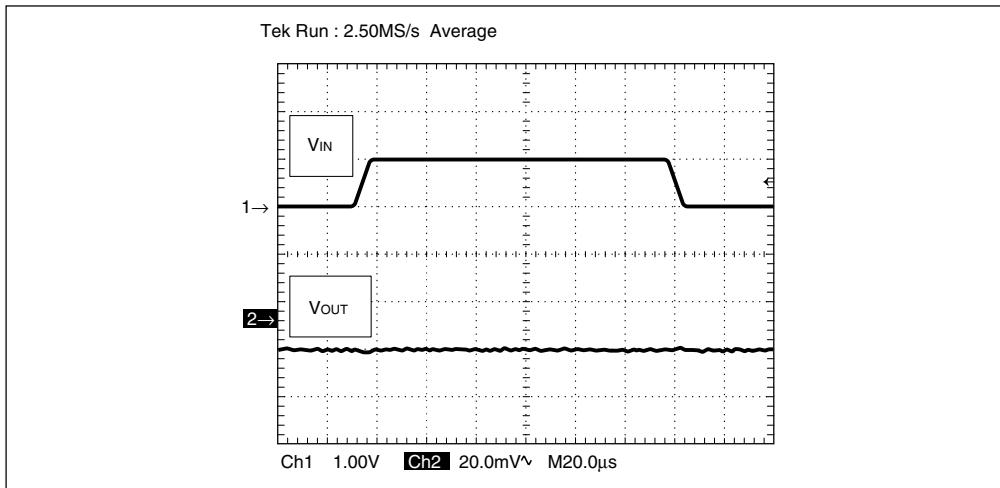
R11x2N301B



9) Input Transient Response

R11x2N151B

T_{opt}=25°C

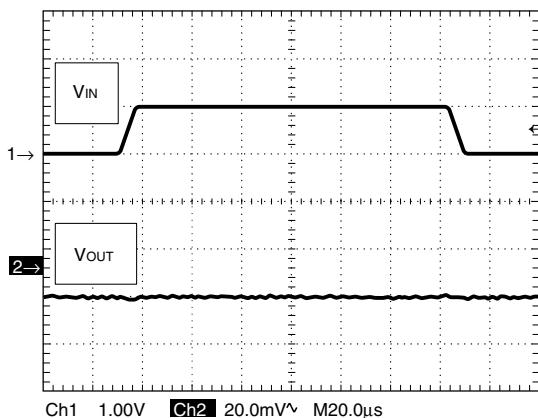


V_{IN}=2.5V↔3.5V
I_{OUT}=30mA
C_{IN}=none
C_{OUT}=2.2μF
tr/tf=5μs

R11x2N201B

Topt=25°C

Tek Run : 2.50MS/s Average

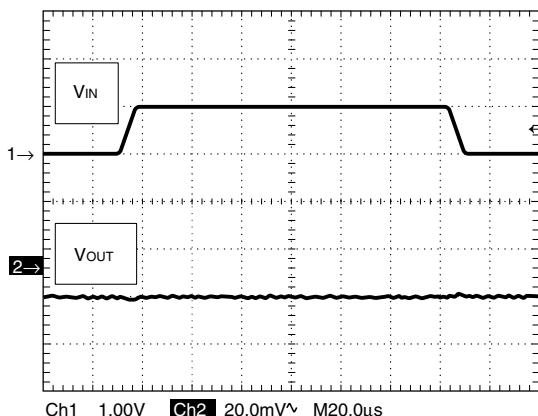


$V_{IN}=3.0V \leftrightarrow 4.0V$
 $I_{OUT}=30mA$
 $C_{IN}=\text{none}$
 $C_{OUT}=2.2\mu F$
 $tr/trf=5\mu s$

R11x2N301B

Topt=25°C

Tek Run : 2.50MS/s Average

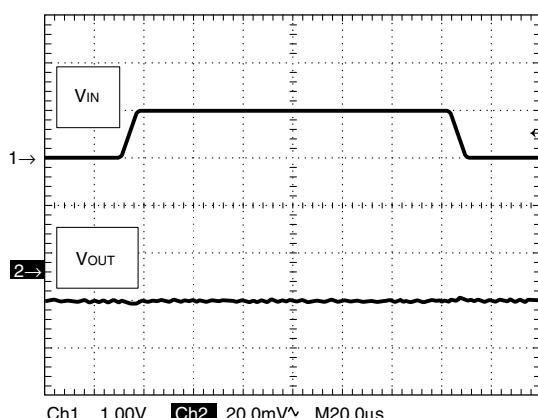


$V_{IN}=4.0V \leftrightarrow 5.0V$
 $I_{OUT}=30mA$
 $C_{IN}=\text{none}$
 $C_{OUT}=2.2\mu F$
 $tr/trf=5\mu s$

R11x2N401B

Topt=25°C

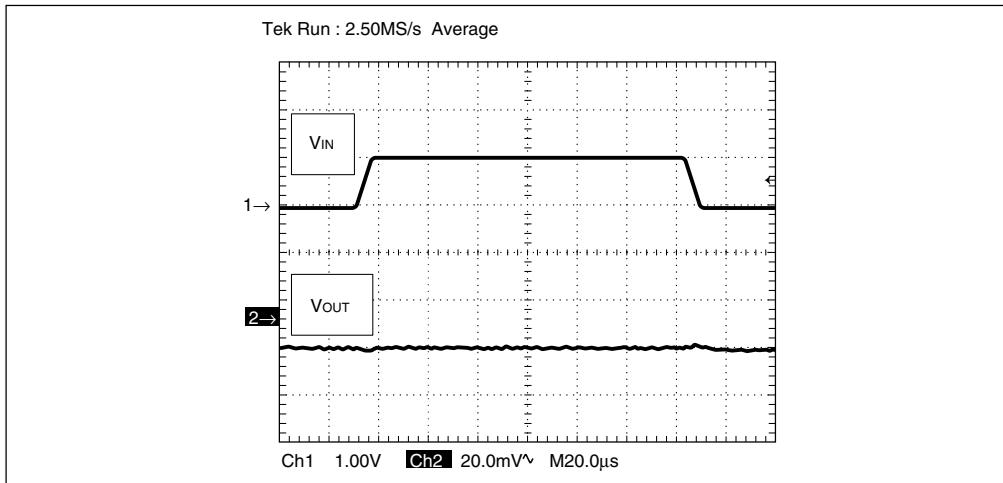
Tek Run : 2.50MS/s Average



$V_{IN}=5.0V \leftrightarrow 6.0V$
 $I_{OUT}=30mA$
 $C_{IN}=\text{none}$
 $C_{OUT}=2.2\mu F$
 $tr/trf=5\mu s$

R11x2N501B

T_{opt}=25°C

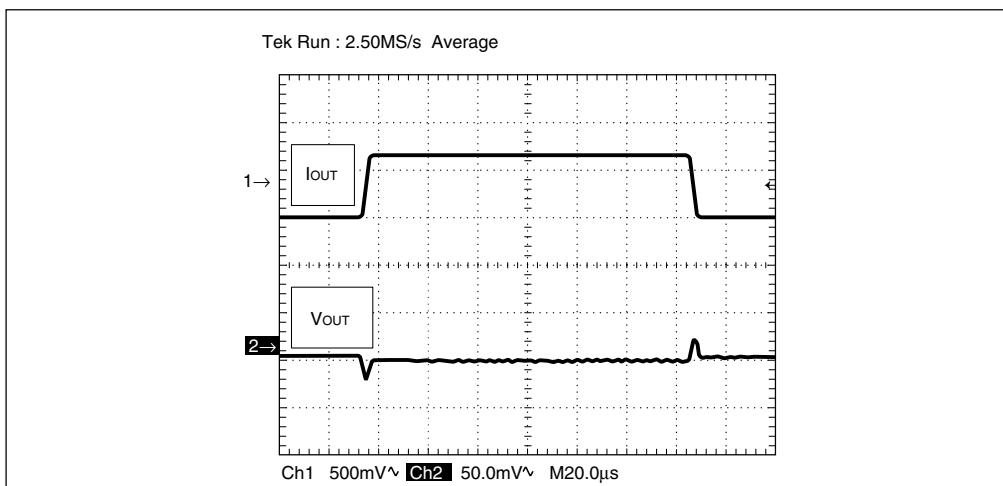


V_{IN}=6.0V↔7.0V
I_{OUT}=30mA
C_{IN}=none
C_{OUT}=2.2μF
tr/tf=5μs

10) Load Transient Response

R11x2N151B

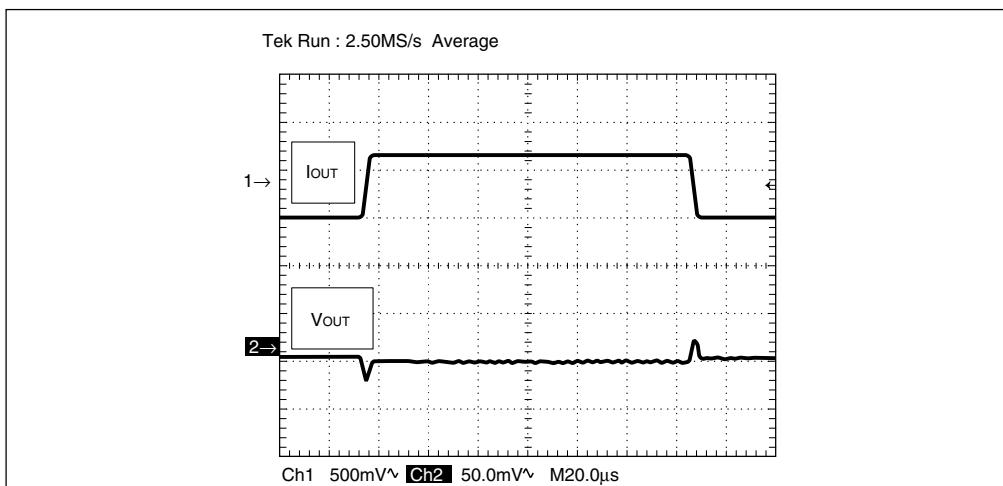
T_{opt}=25°C



I_{OUT}=50mA↔100mA
V_{IN}=2.5V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R11x2N201B

T_{opt}=25°C

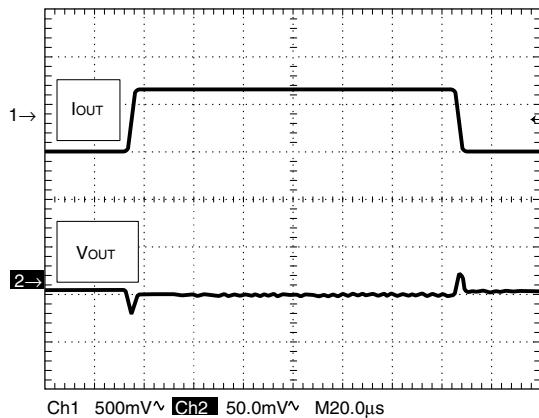


I_{OUT}=50mA↔100mA
V_{IN}=3.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R11x2N301B

Topt=25°C

Tek Run : 2.50MS/s Average

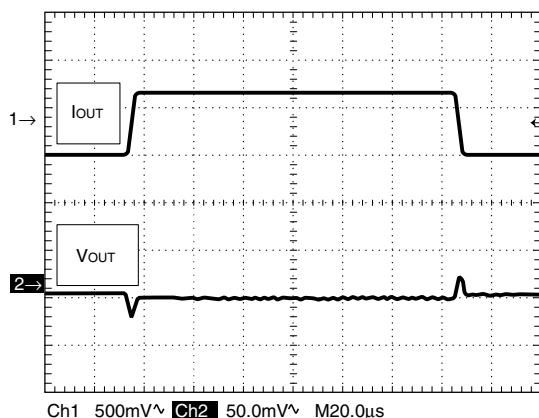


I_{OUT}=50mA↔100mA
V_{IN}=4.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R11x2N401B

Topt=25°C

Tek Run : 2.50MS/s Average

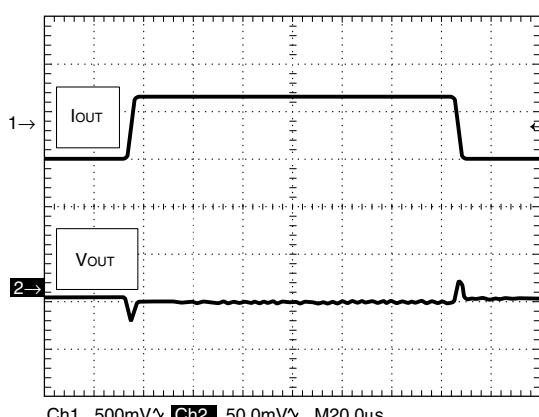


I_{OUT}=50mA↔100mA
V_{IN}=5.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R11x2N501B

Topt=25°C

Tek Run : 2.50MS/s Average

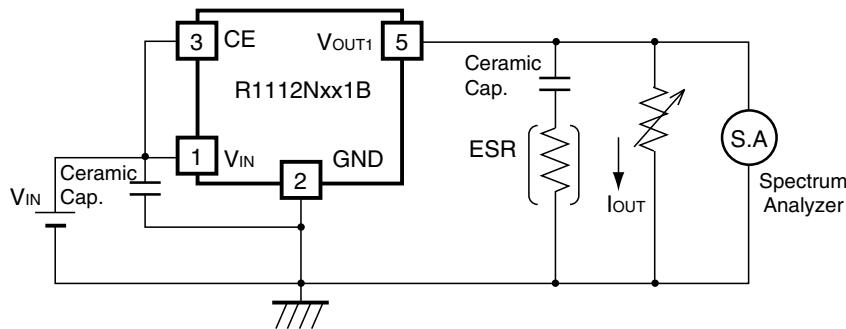


I_{OUT}=50mA↔100mA
V_{IN}=6.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

TECHNICAL NOTES

When using these ICs, consider the following points:

In these ICs, phase compensation is made for securing stable operation even if the load current is varied. For this purpose, be sure to use a capacitor C_{OUT} with good frequency characteristics and ESR (Equivalent Series Resistance) of which is in the range described as follows:



Measuring Circuit for white noise; R1112Nxx1B

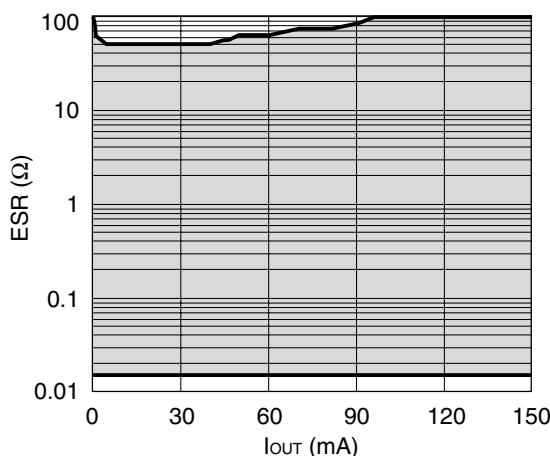
The relationship between I_{OUT} (the output current) and ESR of the output capacitor is shown in the graphs below. The conditions when the white noise level is under $40\mu V$ (Avg.) are indicated by the hatched area in the graph.
 (Note: When additional ceramic capacitors are connected to the output pin with the output capacitor for phase compensation, operation might be unstable. Because of this, test these ICs with the same external components as the ones to be used on the PCB.)

<Measuring Conditions>

- (1) $V_{IN}=V_{OUT}+1V$
- (2) Frequency band: 10Hz to 1MHz
- (3) Temperature: $25^{\circ}C$

R11x2N151B

$C_{OUT}=2.2\mu F, C_{IN}=2.2\mu F$



R11x2N151B

$C_{OUT}=4.7\mu F, C_{IN}=2.2\mu F$

